



## **Sulfur gases**

# Analysis of trace sulfur in propylene with SCD

## Application Note

Energy & Fuels

### **Authors**

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### **Introduction**

COS and H<sub>2</sub>S can be quantified down to ppb levels because these components are separated from the hydrocarbon matrix by the unique selectivity of the Agilent CP-SilicaPLOT column. With selective detection there is no quenching effect, which results in higher sensitivity and reproducibility.



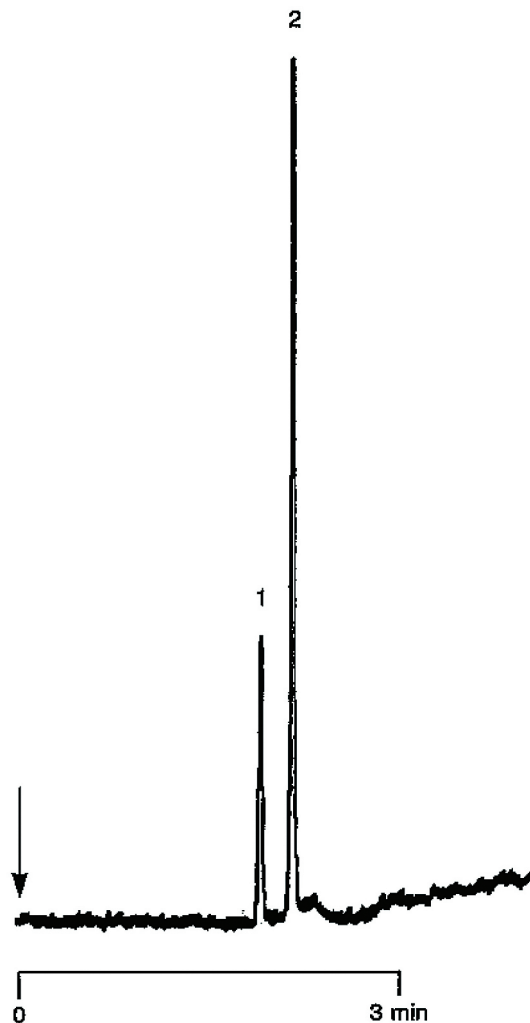
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## Conditions

Technique : GC-capillary  
Column : Agilent CP-SilicaPLOT, 0.32 mm x 30 m, fused silica  
PLOT CP-SilicaPLOT (df = 4  $\mu$ m) (Part no. CP8567)  
Temperature : 50 °C (1 min)  $\rightarrow$  120 °C, 10 °C/min  
Carrier Gas : He, 50 kPa (0.5 bar, 7 psi)  
Injector : Valve  
T = 100 °C  
Detector : Sulfur selective GC detector, Antek  
Sample Size : 0.375 mL  
Concentration Range : sulfur compounds: 1 ppb level  
  
Courtesy : J.F. Borny, Antek Instruments Inc.

## Peak identification

1. carbonyl sulfide (COS) 34 ppb
2. hydrogen sulfide (H<sub>2</sub>S) 108 ppb



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This information is subject to change without notice.

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